onsemi

MOSFET – P-Channel, QFET[®]

-60 V, -47 A, 26 m Ω

FQP47P06

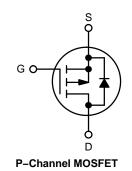
Description

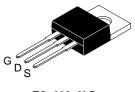
This P-Channel enhancement mode power MOSFET is produced using **onsemi**'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.

Features

- -47 A, -60 V, $R_{DS(on)} = 26 \text{ m}\Omega$ (Max.) @ $V_{GS} = -10 \text{ V}$, $I_D = -23.5 \text{ A}$
- Low Gate Charge (Typ. 84 nC)
- Low Crss (Typ. 320 pF)
- 100% Avalanche Tested
- 175°C Maximum Junction Temperature Rating

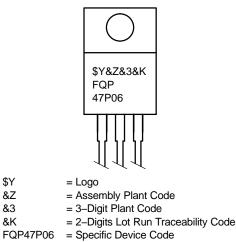
V _{DSS}	R _{DS(on)} MAX	I _D MAX		
–60 V	26 mΩ @ –10 V	–47 A		





TO-220-3LD CASE 340AT

MARKING DIAGRAM



ORDERING INFORMATION

Device	Package	Shipping		
FQP47P06	TO-220-3LD	1000 Units / Tube		

Symbol	Parameter		FQP47P06	Unit
V _{DSS}	Drain-Source Voltage	loltage		
ID	Drain Current	– Continuous ($T_C = 25^{\circ}C$)	-47	А
		– Continuous ($T_C = 100^{\circ}C$)	-33.2	Α
I _{DM}	Drain Current (Note 1)	- Pulsed	-188	Α
V _{GSS}	Gate-Source Voltage		±25	V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		820	mJ
I _{AR}	Avalanche Current (Note 1)		-47	Α
E _{AR}	Repetitive Avalanche Energy (Note 1)		16	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		-7.0	V/ns
PD	Power Dissipation ($T_C = 25^{\circ}C$)		160	W
		– Derate above 25°C	1.06	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +175	°C
TL	Maximum Lead Temperature for Soldering Purposes, 1/8" from Case for 5 Seconds		300	°C

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C unless otherwise specified)

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 0.43 mH, I_{AS} = -47 A, V_{DD} = -25 V, R_G = 25 Ω , Starting T_J = 25°C 3. I_{SD} ≤ -47 A, di/dt ≤ 300A/µs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C

THERMAL CHARACTERISTICS

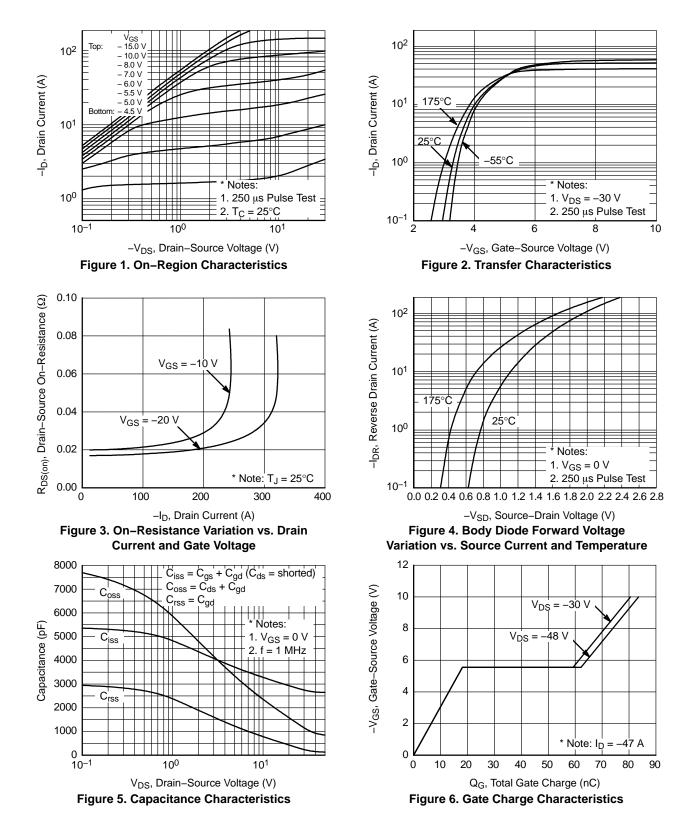
Symbol	ymbol Characteristic		Unit
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction-to-Case, Max.	0.94	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink, Typ.	0.5	°C/W
$R_{ extsf{ heta}JA}$	R _{0JA} Thermal Resistance, Junction-to-Ambient, Max.		°C/W

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHAR	ACTERISTICS	•				
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-60	-	-	V
$\Delta {\rm BV}_{\rm DSS}$ / $\Delta {\rm T}_{\rm J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250 \ \mu$ A, Referenced to 25° C	-	-0.06	-	V/∘C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	-	-	-1	μΑ
		$V_{DS} = -48$ V, $T_{C} = 150^{\circ}C$	-	-	-10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = -25 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$	-	-	-100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = 25 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	100	nA
ON CHARA	ACTERISTICS	-		-	-	-
V _{GS(th})	Gate Threshold Voltage	$V_{DS} = V_{GS}, \ I_D = -250 \ \mu A$	-2.0	-	-4.0	V
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = -10 \text{ V}, \text{ I}_{D} = -23.5 \text{ A}$	-	0.021	0.026	Ω
9FS	Forward Transconductance	$V_{DS} = -30$ V, $I_{D} = -23.5$ A (Note 4)	-	21	-	S
DYNAMIC	CHARACTERISTICS	•				
C _{iss}	Input Capacitance	$V_{DS} = -25$ V, $V_{GS} = 0$ V, f = 1.0 MHz	-	2800	3600	pF
C _{oss}	Output Capacitance		-	1300	1700	pF
C _{rss}	Reverse Transfer Capacitance		-	320	420	pF
SWITCHIN	G CHARACTERISTICS	-				-
t _{d(on)}	Turn–On Delay Time	$V_{DD} = -30$ V, $I_D = -23.5$ A, $R_G = 25$ Ω	-	50	110	ns
t _r	Turn–On Rise Time	- (Note 4, 5)	-	450	910	ns
t _{d(off)}	Turn–Off Delay Time	7	-	100	210	ns
t _f	Turn–Off Fall Time	7	-	195	400	ns
Qg	Total Gate Charge	$V_{DS} = -48$ V, $I_D = -47$ A, $V_{GS} = -10$ V	-	84	110	nC
Q _{gs}	Gate-Source Charge	(Note 4, 5)	-	18	-	nC
Q _{gd}	Gate-Drain Charge		-	44	-	nC
DRAIN-SO	URCE DIODE CHARACTERISTICS AND MAX	IMUM RATING				
۱ _S	Maximum Continuous Drain–Source Diode Forward Current		-	-	-47	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		-	-	-188	А
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = -47 A$	-	-	-4.0	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 V, I_S = -47 A,$ $dI_F / dt = 100 A/\mu s (Note 4)$	-	130	-	ns
Q _{rr}	Reverse Recovery Charge		-	0.55	_	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: Pulse width \leq 300 µs, Duty cycle \leq 2% 5. Essentially independent of operating temperature

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS (Continued)

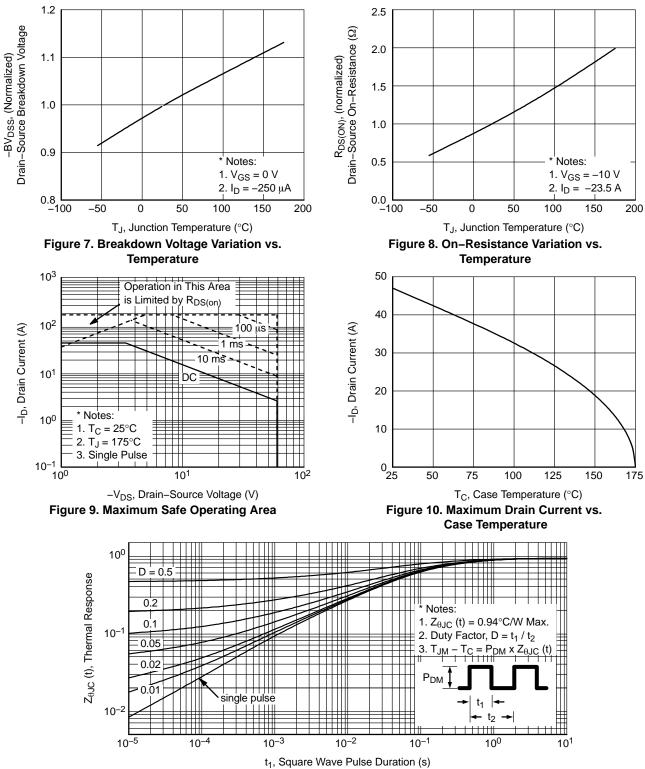


Figure 11. Transient Thermal Response Curve

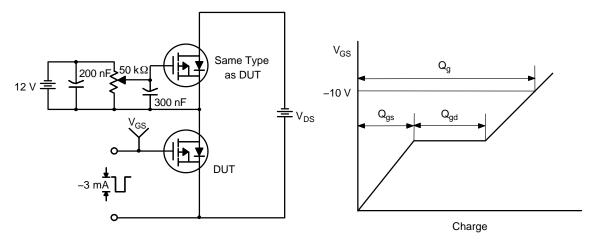


Figure 12. Gate Charge Test Circuit & Waveform

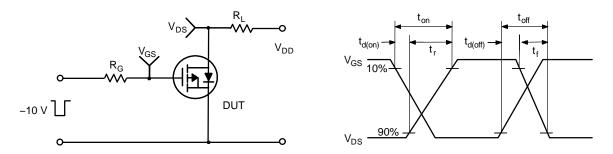


Figure 13. Resistive Switching Test Circuit & Waveforms

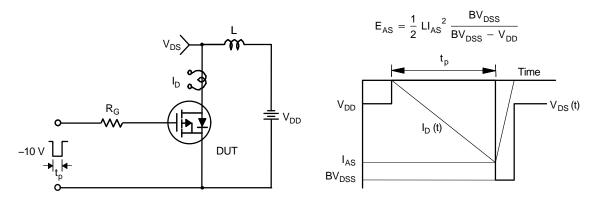


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

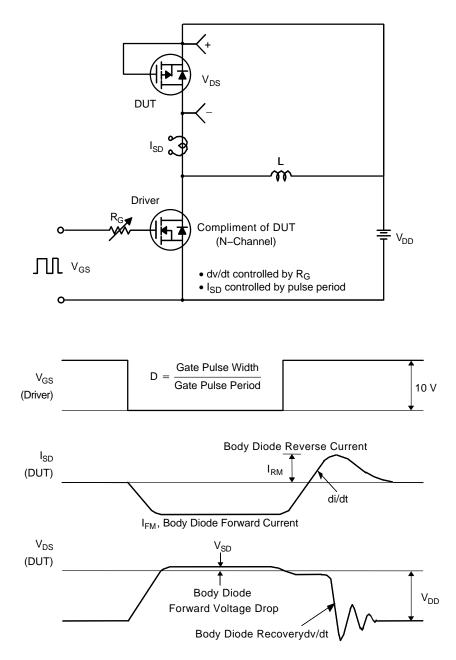
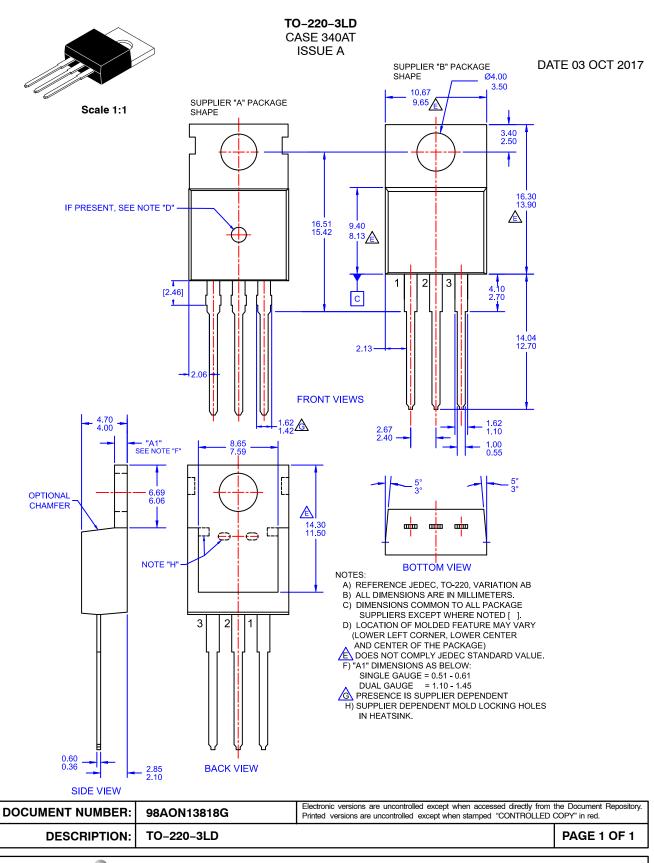


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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